

Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-067001	Application No.
	Applicant Shingo Eguchi et al.		
	Filing Date August 10, 2001	Group Art Unit	

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U.S. Patent Documents							
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
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	AL							
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Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
A.S.	AQ	S. Theiss et al.; International Electron Devices Meeting; San Francisco, CA; December 8-11, pp. 958-959; 1996
	AR	
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